Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/600,236	INOUE, HIRAKU	
Examiner	Art Unit	
Jacon D. Cordono	2145	

SEARCHED				
	SEARCHED			
Class	Subclass	Date	Examiner	
709	253, 208	7/14/2005	JDC	
710	108, 110	7/14/2005	JDC	
710	313, 200	7/15/2005	JDC	
710	200	7/15/2005	JDC	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	:		

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST	7/20/2005	JDC
INSPEC IEEE, google (w/ INSPEC results)	7/20/2005	JDC
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